

Wojciech Żak, on behalf of the Cryomodule Development Team

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SPL Mock-up alignment issues



EUROPEAN
SPALLATION
SOURCE

W. Zak TE-MS-CMI
SLHiPP3 – Louvain-la-neuve 2013

Outline

- Introduction of myself
- SPL Mock-up
- Idea of the Optical Wire Position Monitor
- R&D of the OWPM
- Future tasks

Something about me



Name:

Wojciech

Surname:

Żak

Date of birth: **01.05.1987**

Place of birth: **Pszczyna**

Higher education:

**Masters degree in Power Engineering obtained at
Cracow University of Technology (Mechanical Department)**

Specialization: **Power engineering systems and facilities**

CERN experience:

01.06.2011-31.07.2012

TECHNICAL STUDENT

01.08.2012-31.01.2013

UPAS

01.02.2013-?

FELLOW CERN/ESS

Language skills:

Polish, English, French (une peu), **German** (nicht so gut)



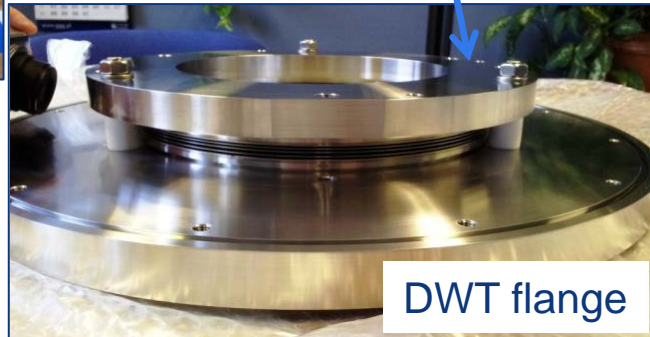
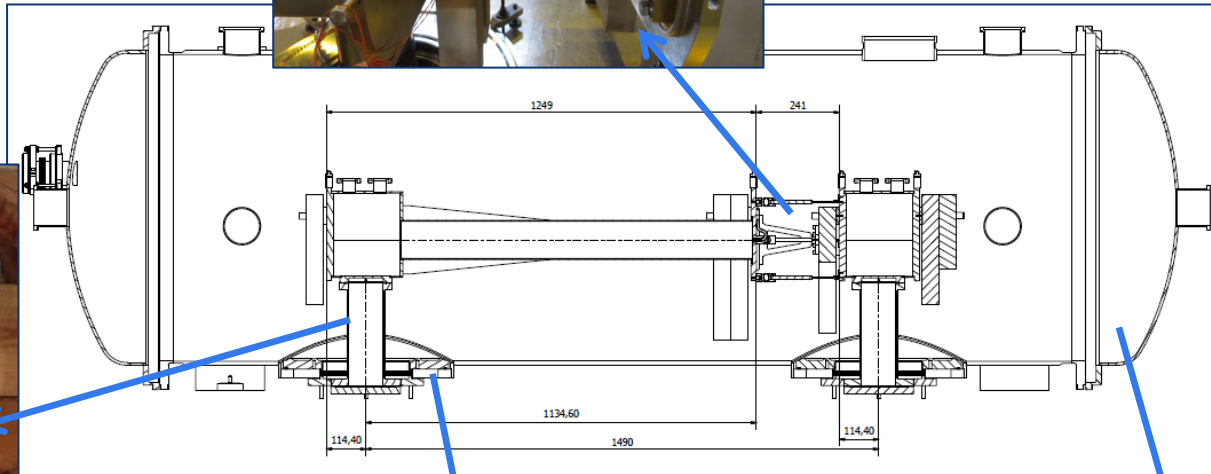
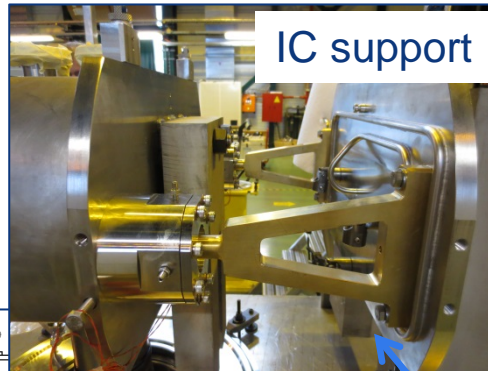
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Mock-up

- Mechanically representative of 1 cavity
- Real DWTs and interfaces to VV
- Cooled by liquid-gas N2
- Aimed at validating:
 - Cavity supporting scheme
 - Alignment measuring devices (OWPM)
 - Realignment of cavities via vessel interface
 - Thermo-mechanical behaviour
 - DWTs active cooling

Mock-up



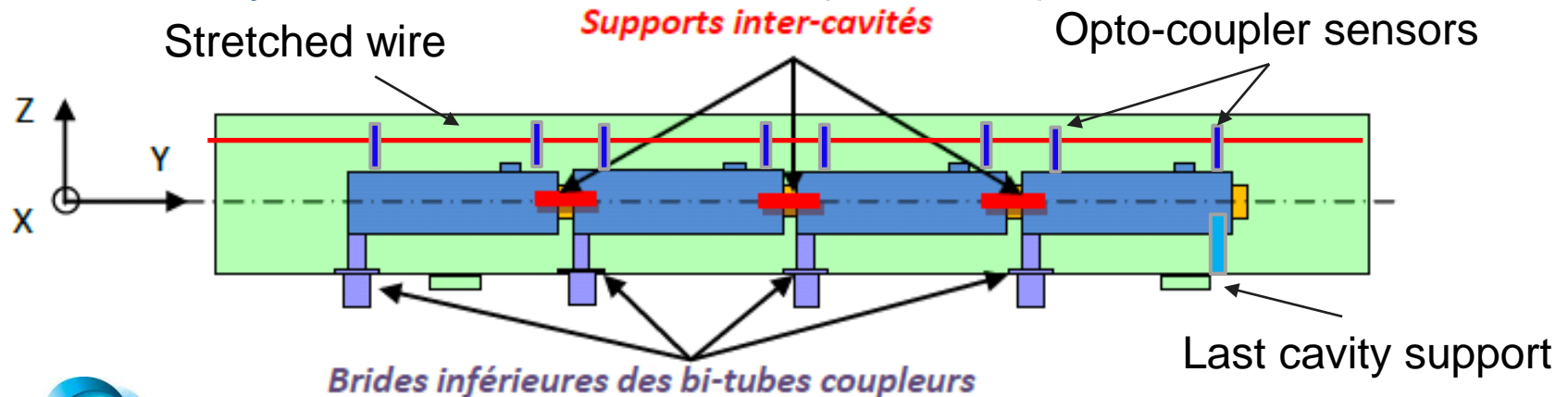
Mock-up – Test program

TEST CONDITION	TEST	COMPONENT / SYSTEM	WHAT	HOW
Room temperature (steady)	<u>Assembly alignment</u>	Assembly not inserted in VV	Obtain assembly alignment at warm (align cavities axes)	Act on DWT lower flange bolts and on ICS bolts to adjust axes of cavities, set zero with laser tracker, then lock
	<u>Alignment sensitivity</u>	Assembly not inserted in VV	Find out sensitivity of alignment system at warm	Act on DWT lower flange bolts and on ICS bolts in a repeatable way, and check the resulting displacements via laser tracker
	<u>Vibration test</u>	Assembly not inserted in VV	Check if vibrations destroy alignment	Vibrations can be generated by a shaker, displacement should be checked via laser tracker
Cold temperature (steady)*	<u>Temperature profile</u>	DWTs	Check accuracy of semi-analytical model / FE simulations of gas-cooled DWTs	Read temp sensors along DWT wall for temperature mapping at cold To have different cooling conditions, change gas N2 mass flow inside the circuit by acting on mass flow controller at gas outlet
	<u>Temperature uniformity</u>	Assembly	Look for temperature differences at cold	Read temp sensors for global temperature mapping at cold
	<u>Liquid N2 quantity / static heat loads</u>	Cavities	Check of liquid nitrogen level inside cavities to get static heat loads	Read level gages inside cavities, act on control valves of N2 dewar to open/close filling circuit
	<u>Mechanical loads</u>	DWTs	Check amount of bending / torsional loads, deformations	Read strain gages on DWT wall to get thermo-mech loads
	<u>Assembly alignment</u>	Assembly	Check assembly alignment at cold	Read OWPM on top of cavity flanges
	<u>Cavities relative position</u>	Cavities	Check displacements btw cavities flanges	Read displacements sensors on flanges btw 2 cavities
Cool down (transient)	<u>Temperature uniformity</u>	Cavities, ICSs	Check temperature uniformity during liquid N2 filling	Continuous read temp sensors on cavities and ICS for dynamic temp mapping
	<u>Temperature uniformity</u>	DWTs	Check temperature uniformity during gas N2 filling	Continuous read temp sensors on DWT wall
	<u>Thermal contractions / stresses</u>	Assembly	Check movements / stresses during cool-down	Continuous check of OWPM, strain gages on DWT wall, ICS and cavity, and displacement sensors btw cavities

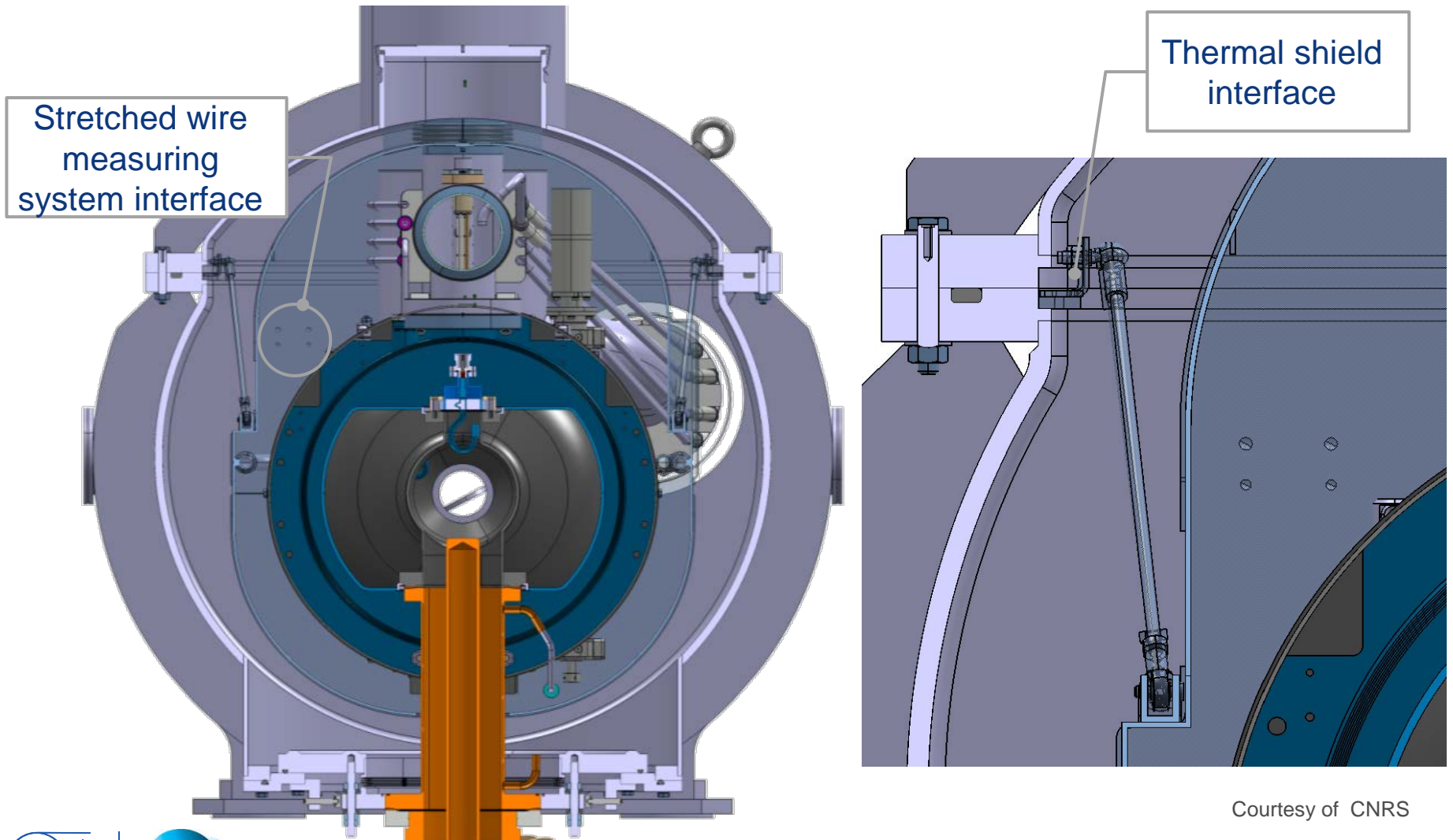
Optical Wire Position Monitor (OWPM)

SPL SCM Cavity position monitoring specs:

- Static position or slow movements: absolute movements (x,y,z) of each of 4 cavities during steady state operation and cool-down/warm-ups (300-2 K)
- Vertical range 0-2 mm
- Precision < 0.05 mm
- Resolution < 0.01 mm
- Possibly vibration measures (0-1 kHz)

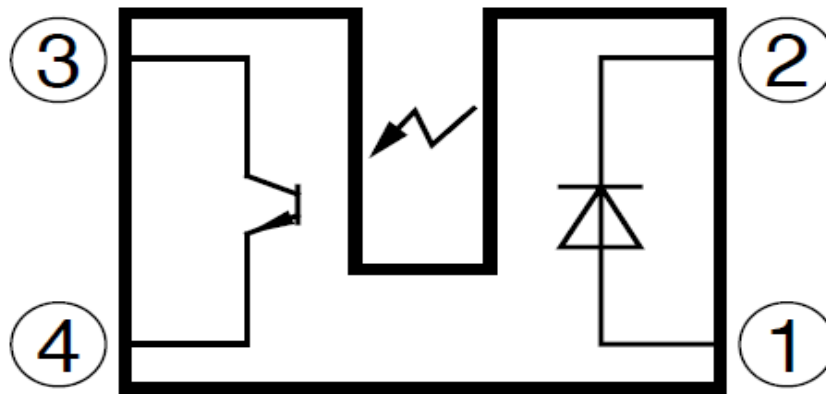


OWPM position on the SPL SCM



Courtesy of CNRS

SHARP GP1S56TJ000F



- ① Anode
- ② Cathode
- ③ Collector
- ④ Emitter

GP1S56TJ000F is a standard, phototransistor output, transmissive photointerrupter with opposing emitter and detector in a case, providing non-contact sensing. For this family of devices, the emitter and detector are inserted

in a case, resulting in a through-hole design.

This device is unique because it uses position pins to insure accurate placement on the PCB, and has the short profile.

SHARP

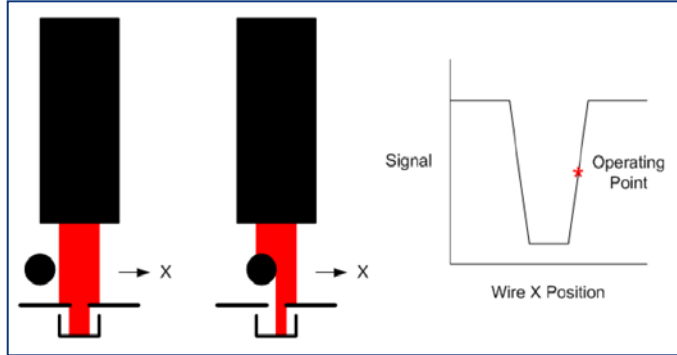


GP1S56TJ000F

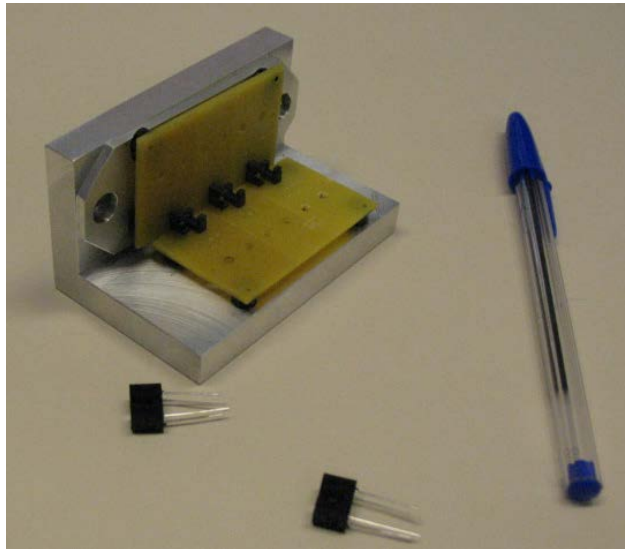
Courtesy of M. Guinchart

Photo-interrupter as displacement measurement devices: R&D in progress

Basic principle

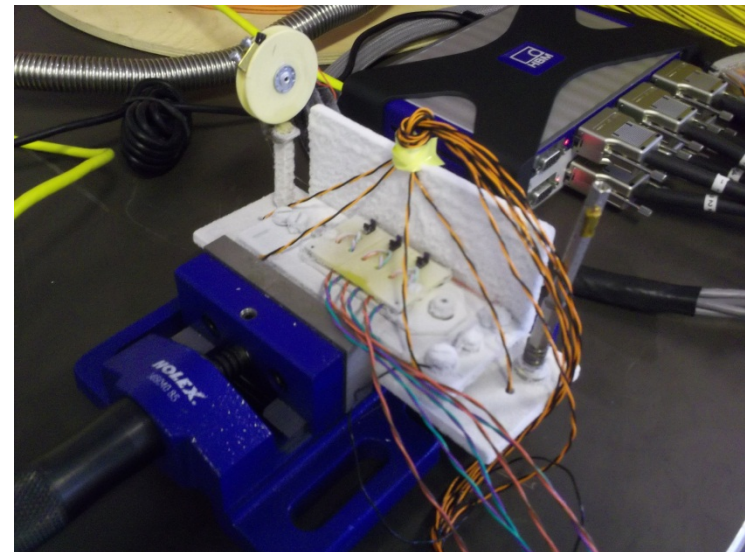


Operating tests in LN2



Courtesy of J. Perez

Multiple interrupters examples

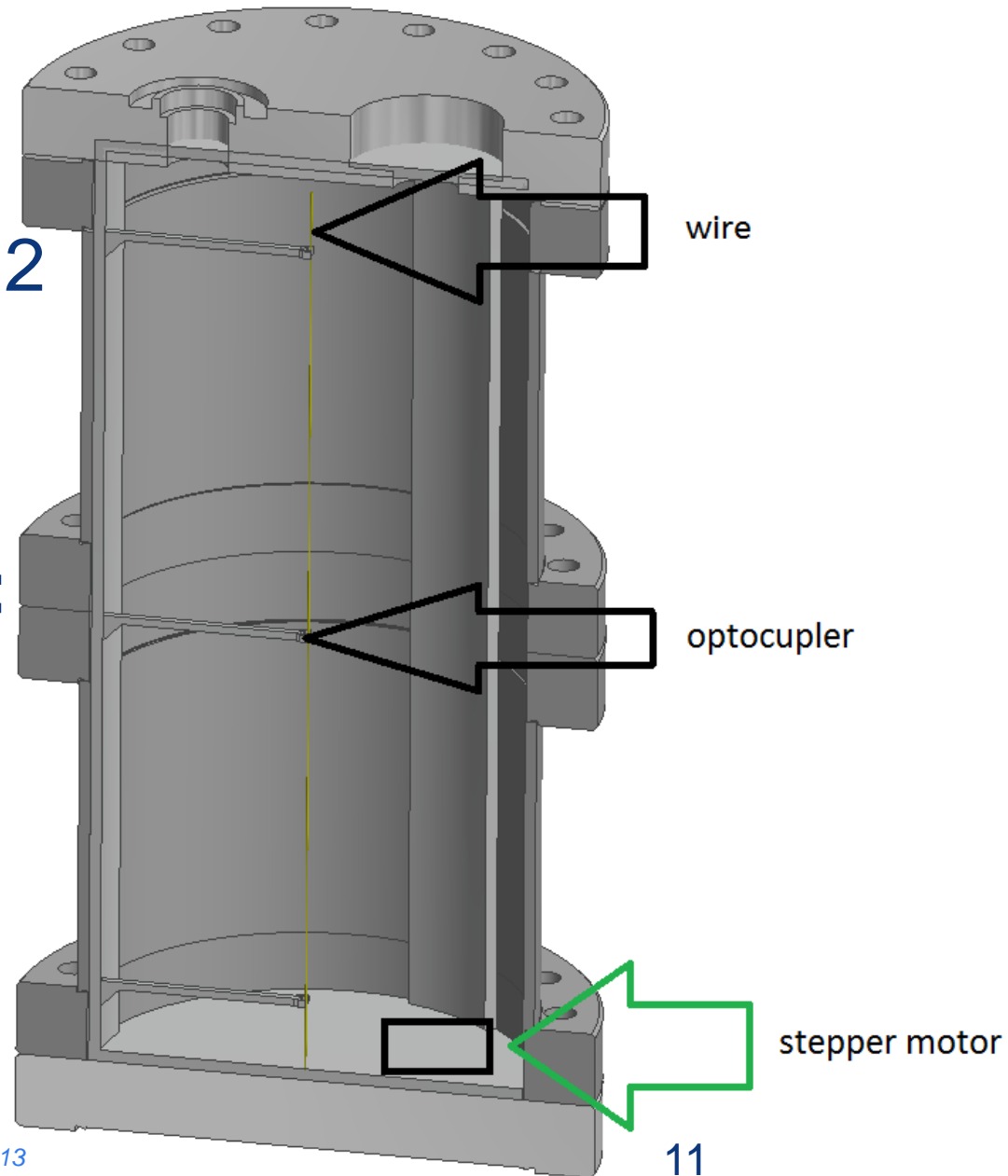


New test concept

- Small cryostat merged in liquid N₂
- Under vacuum
- “Movable” wire

The Aim of the test:

Find out if we can obtain uninterrupted signals from the optocouplers



Future tasks

- Everything depends on the results obtained from our new test mock-up
- In case we obtain satisfying result we will proceed with mounting the system on the SPL mock-up
- If this solution fails we will have to look for something different (for example WPM for XFL)

Thank you for your attention!



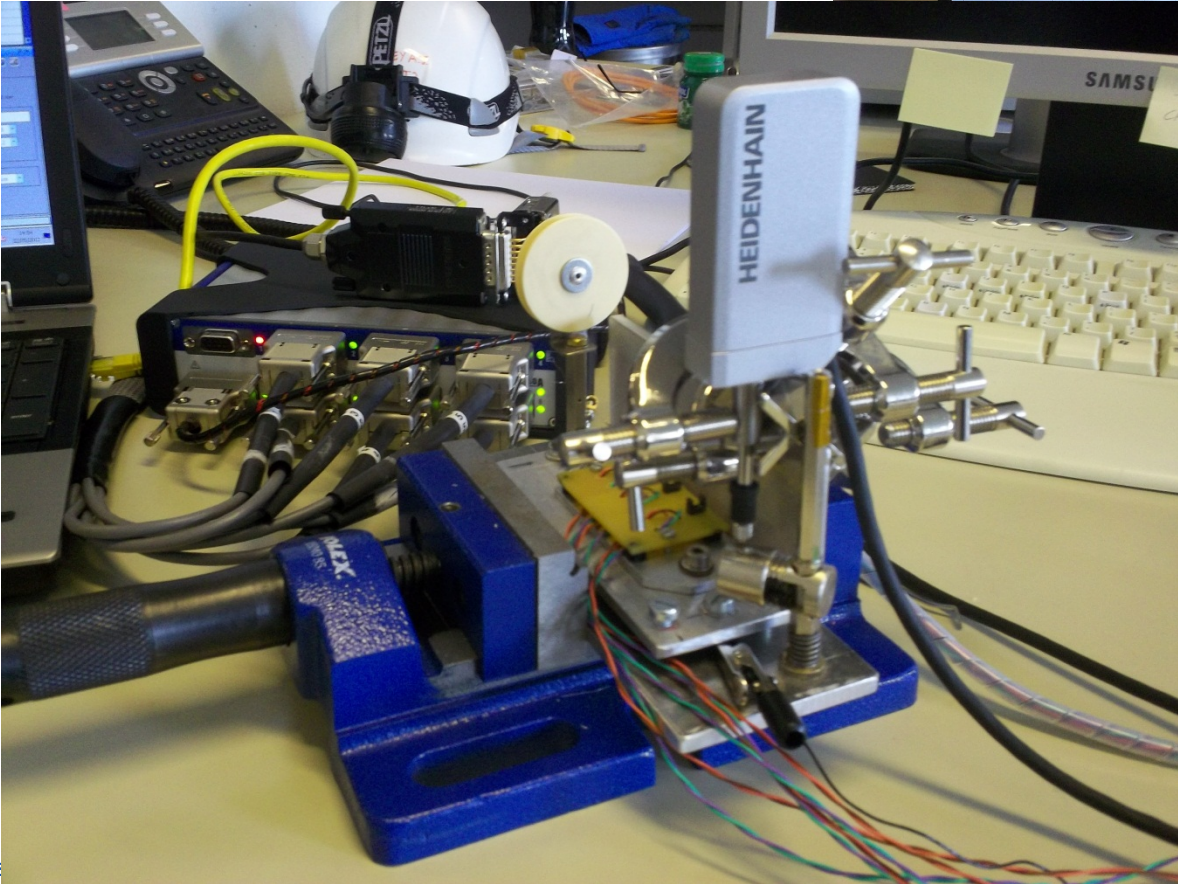
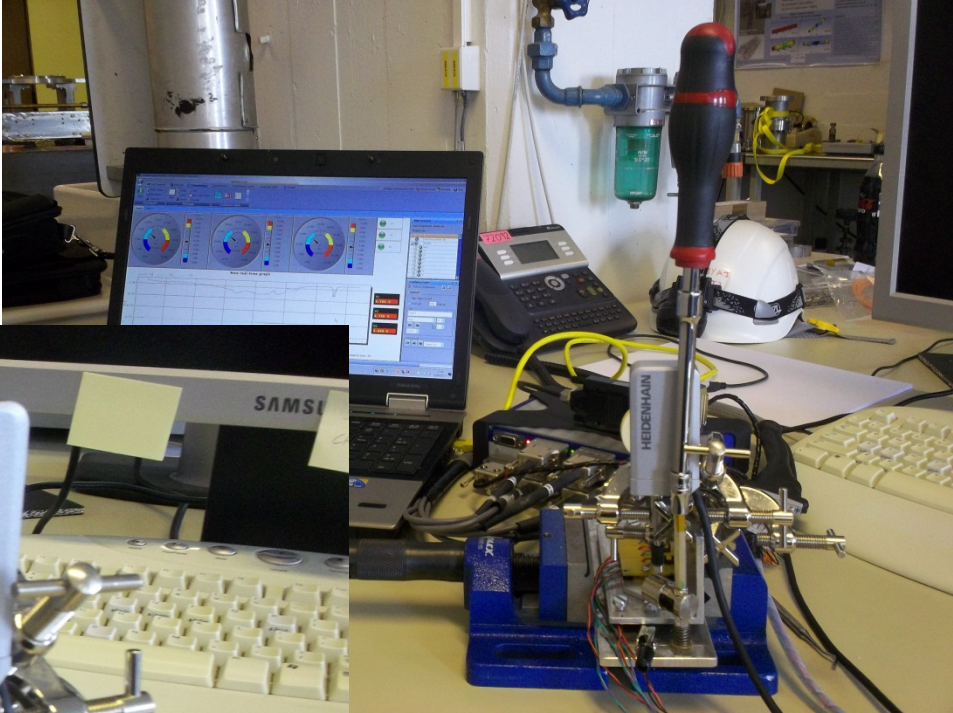
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- **Spare slides**

Calibration with a reference sensor

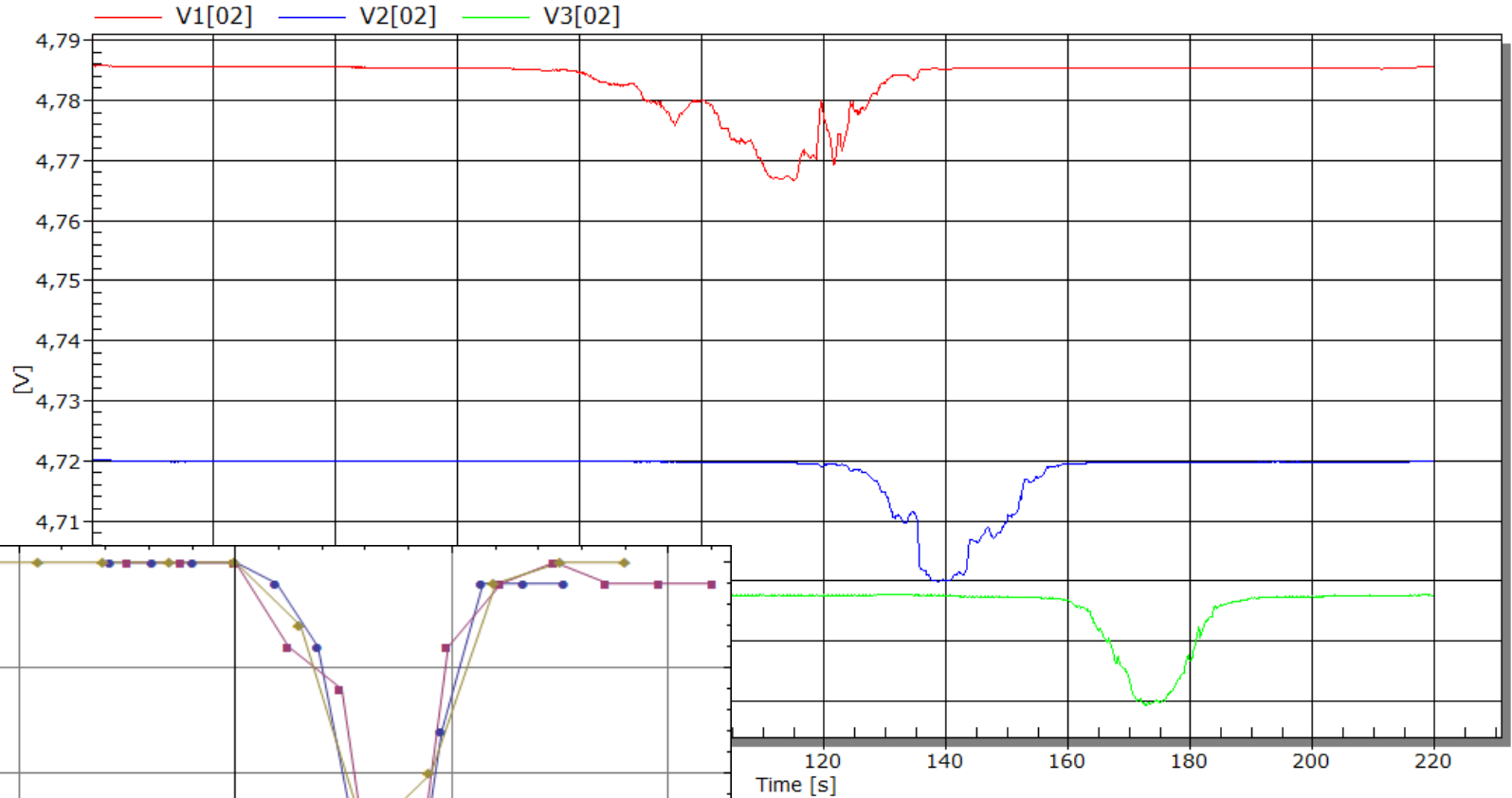
HEIDENHAIN-METRO
Length Gauges with $\pm 0.2 \mu\text{m}$ Accuracy



Courtesy of M. Guinchard



Functional tests



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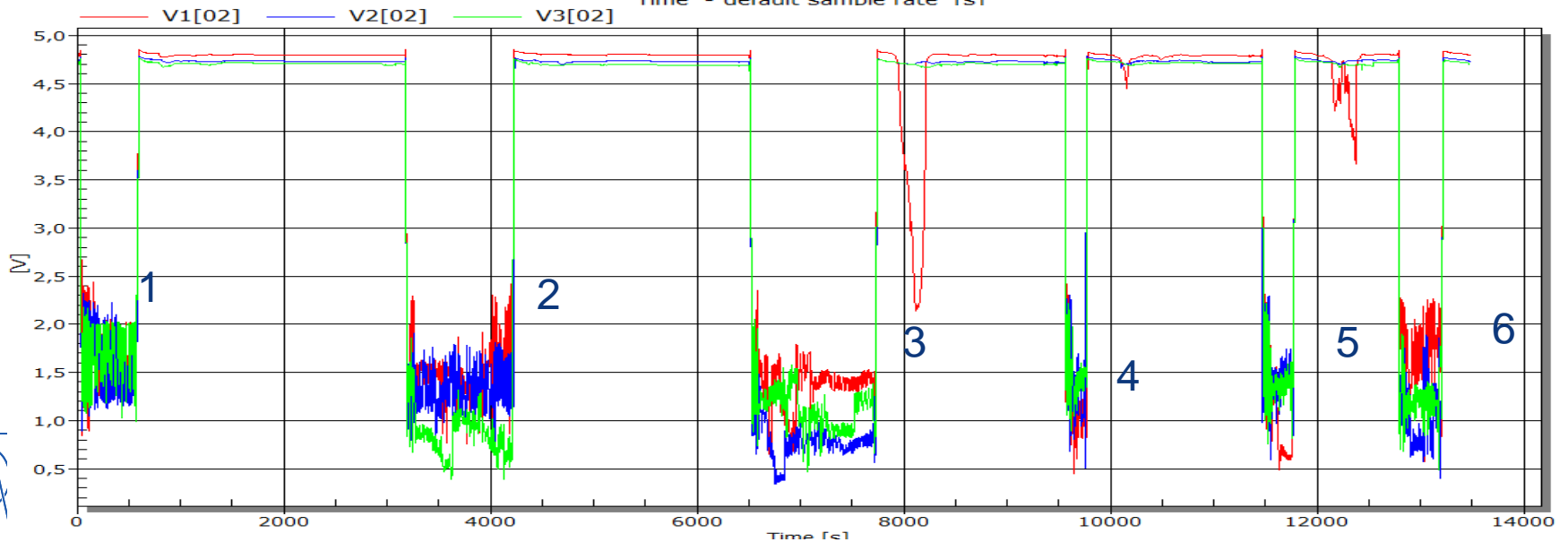
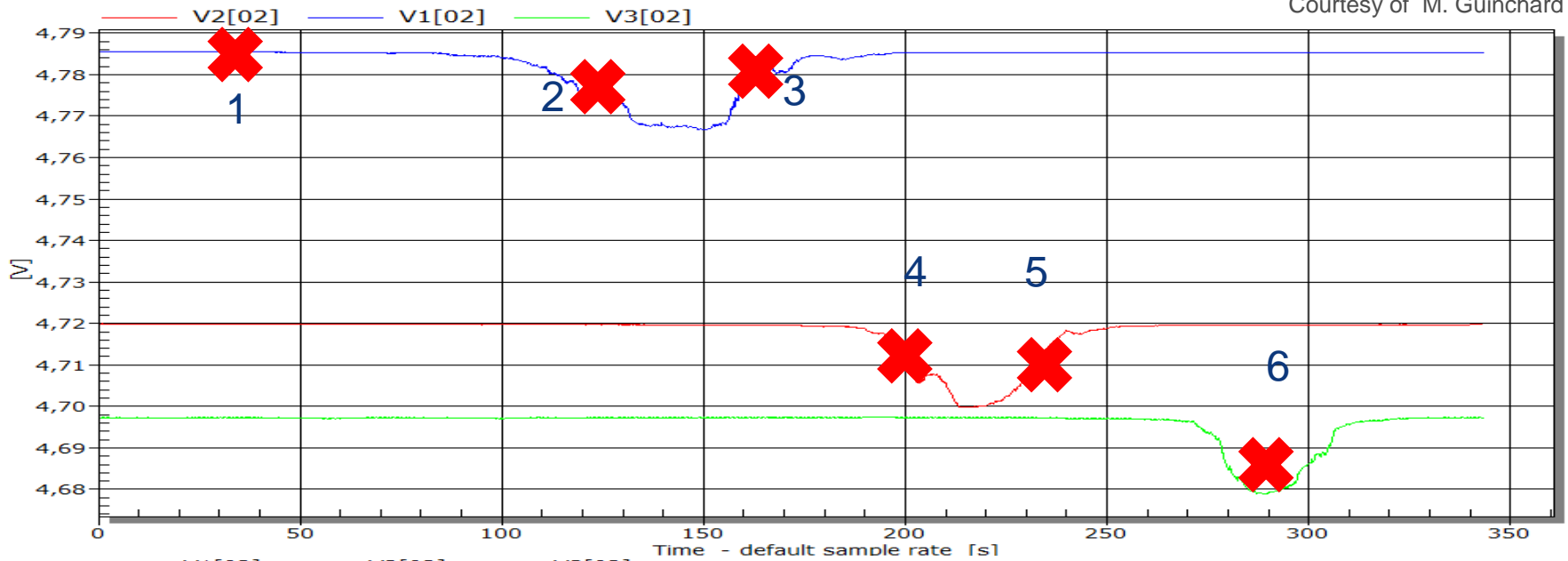
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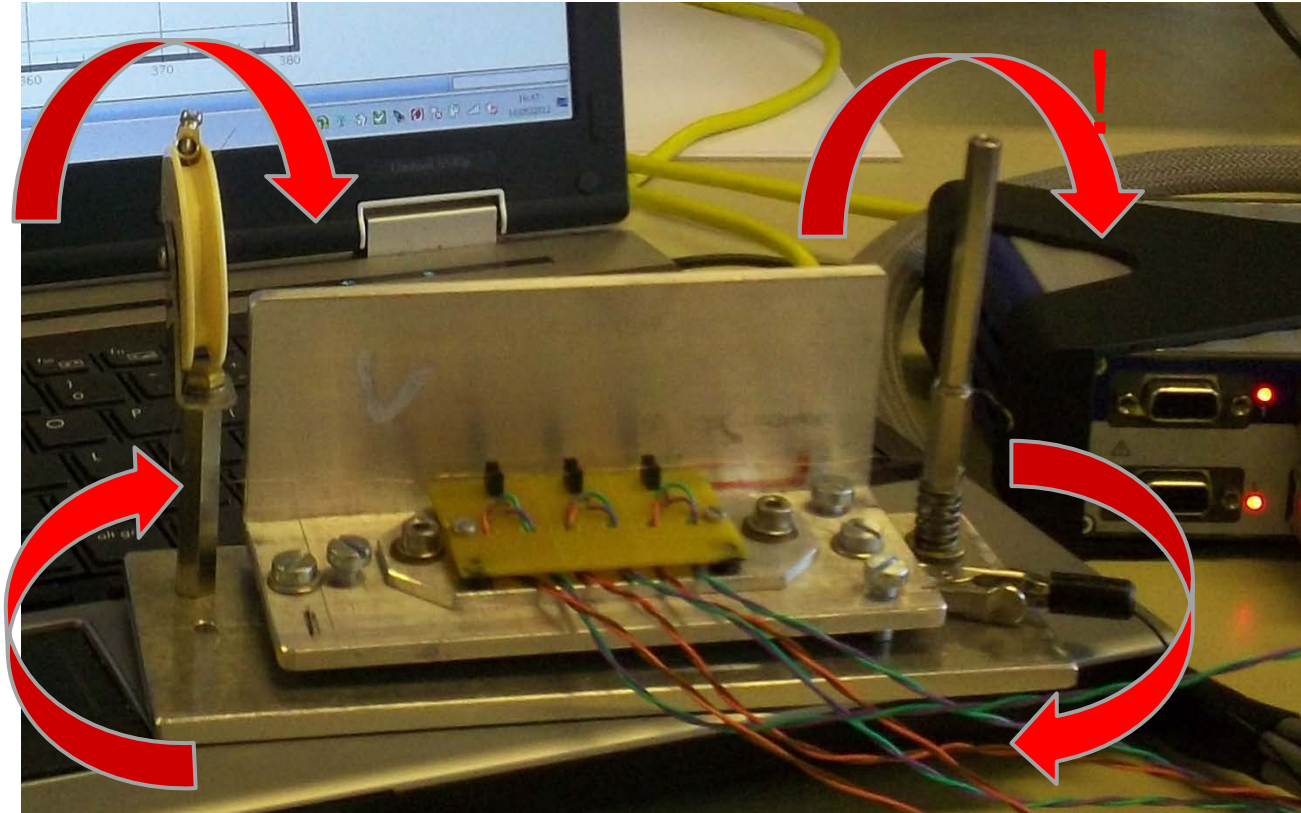
Functional tests at 77 K

Courtesy of M. Guinchard



Functional tests at 77K

Courtesy of M. Guinchard



Thermal deformation measurement system are so large that finding the correctness or incorrectness of its operation is impossible.

Deformations which can not be compensated for are:
support,
mounting system,
mounting bracket
cable,
support of the
thermal
compensation circuit
wire.

The last two elements are fundamentally changing the geometry of the system, making it impossible to make the validation of measurements